Se	earch Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/523,832	CHING ET AL.	
Examiner	Art Unit	
Marc D. Thompson	2144	

	SEARCHED			
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
203, 217	10/13/2005	MDT		
36,115	10/13/2005	MDT		
<u> </u>				
	Subclass 203, 217	Subclass Date 203, 217 10/13/2005		

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
updated class/subclass search: USPGPUB, USPAT, EPO, DERWENT	10/13/2005	MDT
updated NPL full text search: IEEE, ACM	10/13/2005	MDT